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Application/Control No.	Applicant(s)/Patent under Reexamination
10/796,175	ARAKAWA ET AL.
Examiner	Art Unit
Yicun Wu	2165

	SEARCHED				
Class	Class Subclass Date		Examiner		
707	1,2,3,4 5,6,7,8 9,10, 100	7/20/05	١		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
7.7	204	14/7/05	yw		
707	201				
707	204	4/11/05	yw		
707.	201	4/11/06	yW		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
inventor search (double patenting) uspto uspgpub usocr epo jpo ibmtech derwent	7/2/05	7	
acm leee citeseer internet Search stratagy attached	$\dot{\nu}$		
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